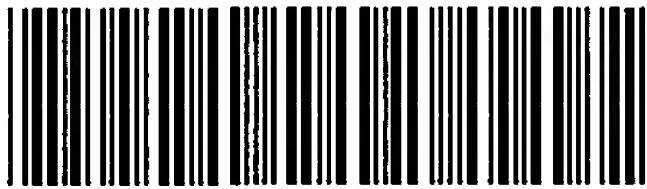


**Search Notes**

Application/Control No.

10/606,396

Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

GERMAIN ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	676	5/1/2005	TT
257	782-784	5/1/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR